


<b>Search Notes</b>  	<b>Application/Control No.</b>  10517238	<b>Applicant(s)/Patent Under Reexamination</b>  BAUMER ET AL.
	<b>Examiner</b>  Binh X Tran	<b>Art Unit</b>  1792

SEARCHED			
Class	Subclass	Date	Examiner
427	421.1, 427.4, 427.7	4/30/2009	BT

SEARCH NOTES		
Search Notes	Date	Examiner
Update inventor's name search	4/30/2009	BT
Update keywords search using databases in EAST	4/30/2009	BT

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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